Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,047	HABIB ET AL.	
Examiner	Art Unit	
Steven J. Ganey	3752	

Steven J. Ganey

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Class	Subclass	Date	Examiner
239	461 566 567 589 750 752 753		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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